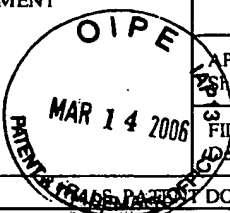


Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 117965		APPLICATION NO. New U.S. Patent Application  <b>10/725,427</b>	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANTS Shuichi EZAKI et al.			
				FILING DATE December 3, 2003			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	1	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
<i>VL</i>		5,931,142	08/03/1999	GERLING			
<i>repeated</i>	<i>2</i>	<del>5,873,335</del>	<del>02/23/1999</del>	<del>WRIGHT et al.</del>			
<i>on 4/29/04 IDS</i>							
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
<i>VL</i>	3	JP A 2001-152820 w/ abst & trans	06/05/2001	Japan			
<i>VL</i>	4	JP A 8-177536 w/ abst & trans	07/09/1996	Japan			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			
<i>Wing Chung</i>				<i>03/30/06</i>			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: December 3, 2003

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 117965		APPLICATION NO. 10/725,427	
<b>INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)							
				APPLICANTS Shuichi EZAKI et al.			
				FILING DATE December 3, 2003			
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initials	Cite No.	Document Number	Date	Name			
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
<i>ll</i>	1.	WO 02/084082 A1	10/24/2002	WIPO	X		
<i>ll</i>	2.	EP 0 469 702 A2	02/05/1992	Europe			
<b>OTHER DOCUMENTS</b>							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
<i>ll</i>	3.	English Translation of Chinese Office Action - Application No. 200310119796.4 - January 20, 2006					
EXAMINER				DATE CONSIDERED			
<i>Shing Wang</i>				<i>02/20/06</i>			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: March 14, 2006

Form PTO-1449  
(REV. 8-83)US Dept. of Commerce  
PATENT & TRADEMARK OFFICEATTY DOCKET NO.  
117965APPLICATION NO.  
10/725,427

## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS  
Shuichi EZAKI et al.FILING DATE  
December 3, 2003

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>ll</i>	1	5,873,335	02/23/1999	WRIGHT et al.	<del></del>	<del></del>
<i>ll</i>	2	5,331,931	07/26/1994	BLISH et al.	<del></del>	<del></del>
<i>ll</i>	3	5,598,814	02/04/1997	SHROEDER et al.	<del></del>	<del></del>

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
<i>ll</i>	4	FR 2 823 529 A1	10/18/1992	France	<del></del>	<del></del>
<i>ll</i>	5	DE 198 25 964 A 1	12/16/1999	Germany	<del></del>	<del></del>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)


EXAMINER

*Ching Chany*

DATE CONSIDERED

*2/20/06*

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: April 29, 2004